Contact Image Sensor
(CIS) Module

Product Name	M106-A4-G1

A	pproval		No	otes	
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All specifications of this device are subject to change without notice.					

Revision control sheet

Revision No.	Date	Item of change and content	Reason	Approved	Designed
V1.0	10/7/08	Correct dimension to 15mm x18mmx 232mm			

CMOS Sensor Inc.

M106-A4-G1

8 dpm Compact Image Sensor (CIS) module

Features:

- 1728 x 1 image sensing elements
- 8 dots per millimeter (dpm) resolution
- 216 mm scanning length
- 15 mm x 18 mm x 232 mm compact size
- 5 ms/line scanning speed
- Yellow green LED light source
- high MTF
- light weight
- low power consumption
- one analog output signal
- high integration for light source, lens and sensor
- 10 pin connector for input and output

Description:

The M106-A4-G1 compact image sensor module is a contact type image sensing module that is composed of a line of LED's as a light source, a long Selfoc rod lens array, and 1728 pixels of the photo-detector array. Input and output electronic contact is via a seven - pin connector. The cross sectional view of the M106-A4-G1 is shown in figure 1. Figure 2, on the following page, is a block diagram of the module.

The module is suitable to scan an A4 size (216 mm) document. Applications include fax machine, document scanner, mark reader, and other office automation equipment.





Functional block diagram:



Figure 2 Functional block diagram of M106-A4-G1.

Pin Description:

Pin #	Symbol	Description
1	VLED	LED power supply voltage; 5V
2	GLED	LED power supply ground; 0 V
3	фср	Main clock pulse
4	Gnd	Power supply ground; 0 V
5	ф _{SP}	Start pulse
6	Gnd	Power supply ground; 0 V
7	Gnd	Power supply ground; 0 V
8	V _{DD}	Power supply voltage; 5 V
9	Gnd	Power supply ground; 0 V
10	V _{out}	Analog video output signal

Electro-optical characteristics:

at f = 500 kHz, $V_{DD} = 5 \text{ V}$, VLED = 5 V, $T_{int}^{*(1)} = 5 \text{ ms}$, $\lambda^{*(2)} = 570 \text{ nm}$, $Ta^{*(3)} = 25 \text{ °C}$ (unless otherwise noted)

symbol	Parameter	test conditions	min.	typ	max	unit
$V_{p}^{*(4)}$	Analog output voltage at white paper	O.D. $^{*(11)} = 0.05 \sim 0.1$	1.8	2.0	2.2	V
$U_{p}^{*(5)}$	White paper non-uniformity	O.D. = 0.05 ~ 0.1	-30		30	%
U _{padj} ^{*(6)}	Adjacent pixel non-uniformity	O.D. = 0.05 ~ 0.1	-25		25	%
$V_{d}^{*(7)}$	Analog output voltage at dark paper	light off, $O.D. = 0.8$	-200		+200	mV
$U_{d}^{*(8)}$	Dark signal non-uniformity	light off, $O.D. = 0.8$			200	mV
MTF ^{*(9)}	Modulation transfer function	at 3.85 lp/mm ^{*(12)}	30			%
$\gamma^{*(10)}$	Linearity		0.85		1.1	

Definition:

- 1. T_{int} is an integration time. It is determined by the interval between two start pulses.
- 2. λ is a wavelength of the light source.
- 3. Ta is ambient temperature.
- 4. Vp = (Vpmax + Vpmin) / 2

where Vpmax is a maximum voltage of whole module on white document. Vpmin is a minimum voltage of whole module on white document.

- 5. Up is a pixel pixel photo response non-uniformity within whole module. Up = [(Vpmax - Vpmin) / Vp] x 100%
- 6. Upadj = Max [$|(Vp(i) Vp(i+1)| / Vp(i)] \times 100\%$

where Vp(i) is the video signal output of each pixel # i

Vp(i+1) is the video signal output of each pixel # (i+1)

7. Vd = (Vdmax + Vdmin) / 2

where Vdmax is a maximum dark signal on whole module.

Vdmin is a minimum dark voltage on whole module.

- 8. Ud = Vdmax Vdmin
- 9. $MTF = [(Vmax Vmin) / (Vmax + Vmin)] \times 100\%$

where Vmax is the maximum output voltage at 3.85 lp/mm document.

Vmin is the minimum output voltage at 3.85 lp/mm document.

10. $\gamma = \log[(V2-Vd) / (V1-Vd)] / \log (E2/E1)$ or $\log [(V2 - Vd) / (V1 - Vd)] / \log (T2/T1)$

where V1 is the output voltage of E1 illumination or T1 integration time

V2 is the output voltage of E2 illumination or T2 integration time

at $10 \sim 90\%$ of saturation conduction.

11. O.D. = optical density of the paper.

12. lp / mm = line pair per millimeter

Absolute maximum ratings:

Parameter Name	Symbol	Max	Units
		Value	
Power supply voltage	Vdd	6	V
Power supply current	Idd	40	mA
LED light power supply	VLED	5	V
voltage			
LED light power supply current	ILED	300	mA
Digital input voltage range high	Vih	5.5	V
Digital input voltage range low	Vil	-0.5	V
Operating temperature	Та	0 ~ 50	С
Storage temperature	Tstg	-25 ~ 70	С

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress rating only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Recommended operating conditions:

Item	Symbol	Min.	Тур.	Max.	Unit
Positive power supply voltage	V _{DD}	4.75	5	5.25	V
Negative power supply voltage	Vss	- 4.5	- 5	- 5.5	V
LED power supply voltage	V _{LED}		5		V
High level input voltage	V _{IH}	3.4	5	5.5	V
Low level input voltage	V _{IL}	-0.5	0	0.5	V
Clock frequency	F		500	600	kHz
Clock pulse high duty cycle			25		%
Clock pulse high duration	Tw		0.5	1.0	us
Wavelength of light source	λ		570		nm
Operating free-air temperature	Та	0	25	50	°C

Timing Diagram:



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item	description	Symbol	min.	typ.	max.	unit
1	clock cycle time	То		2		us
2	clock pulse duty cycle			25		%
3	clock pulse width	Tw		500		ns
4	ϕ_{SP} setup time	Tss	50			ns
5	ϕ_{SP} hold time	Tsh	50			ns
6	Video signal delay time	Td			1000	ns
7	Video signal invalid time	Ti			300	ns
8	Video signal stable time	Ts	100			ns

Switching characteristics:

Switching waveforms:



PRODUCT RELIABILITY TESTS

Items of Test	Testing Conditions	Inspection items	Pass Criterions
	$Temp = 25 \pm 5 {}^{\circ}C,$	$\Delta V p$, $\Delta V d$: the change	$-30 \% < \Delta Vp < 10 \%$
Life Test	Humidity = $20 \sim 80 \text{ RH}\%$	of Vp, Vd respectively	$-25 \text{ mV} < \Delta \text{Vd} < 15 \text{mV}$
	Time = 2000 hrs	after the life testing.	
High Temp Test	Temp = $80 \pm 5 ^{\circ}C$		Parameters must be
	Time = 144 hrs	electrical parameters,	within specs, no
Low Temp Test	Temp = -30 ± 5 °C	module structures.	change, no damage
	Time $= 144$ hrs		in module structures
Temp/Humidity	Temp = 50 ± 5 °C,	Δ Vp: the change of Vp	$-30\% < \Delta Vp < 10\%$
Test	Humidity = 85 ± 5 RH%	after the life testing.	
	Time = 144 hrs		
Temp Cycling	Temp = -30, 25, 80 °C		
	Time = 30, 5, 30 min.		
	Cycles = 10, 50	Electrical parameters,	All electrical
Drop Test	Packaged product drops	Module structures.	parameters must be
	from 1 m height.		within the specs.
	Perform test for 3 sides.		No distortion and
	Cycling: 10 ~ 50 ~ 10 Hz		damage on module.
Vibration Test	Cycle time = 1 min		
	Amp = 2 mm, $Time = 1 Hr$		

Precautions before use:

1. Dirty Glass Surface:

The glass surface should be kept clean.

Do not wipe the sensor by hand or use in a dust polluted environment. Should the glass surface become dirty, moisten a cloth with alcohol and wipe the surface gently. Care should be taken so as not to scratch the surface while wiping it. Any loose dust lying on the sensor surface can be cleaned using an air gun.

2. Dust and the CIS unit

The unit is housed in an air tight structure to protect it from dust. The side plates should not be removed, or dust may enter the unit. When using the side holes to adjust the sensor, turn the screws slowly until tight, so as not to damage the screw hole thread.

3. Extracting / Inserting the connector

The maximum number of times that the connector should be extracted and connected is ten. If the connector is inserted / extracted more than ten times, the connector "burrs" will be eroded, thereby making the connector ineffective.

4. Stable operation

4.1 The connector pins should not be touched by bare hand or Electro-statically charged material.

4.2 Noise:

- a. Insert a low frequency noise suppressing capacitor (100 μ F) between V_{DD} (+5 V) and Gnd. A high frequency noise suppressing capacitor is already integrated into the circuit.
- b. Ensure that the sensor connecting cables are 30 cm or less in length. The ϕ_{CP} and Gnd, ϕ_{SP} and Gnd respectively from twisted cable pairs.

4.3 Latch Up

When the voltage is higher than the absolute maximum, "latch up" will cause the sensor to break, even if the voltage is caused by a surge. If the current varies rapidly in the external circuit, or if the power is turned off and then on again, ensure that the voltage on each terminal does not exceed the values indicated in "absolute maximum rating".

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Attachment: the configuration and the physical dimensions (unit: mm)



M106-A4-G1 configuration and physical dimensions.